

STB80NF03L-04

N-channel 30 V, 0.0035 Ω, 80 A, I²PAK STripFET™ II Power MOSFET

Features

Туре	V _{DSS}	R _{DS(on)}	I _D
STB80NF03L-04	30V	< 0.004Ω	80A

- Exceptional dv/dt capability
- 100% avalanche tested
- Low threshold drive

Application

- Switching applications
 - Automotive

Description

This Power MOSFET is the latest development of STMicroelectronics unique "single feature size" strip based process. The resulting transistor shows extremely high packing density for low onresistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

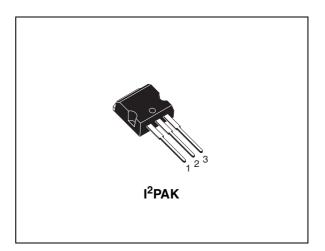


Figure 1. Internal schematic diagram

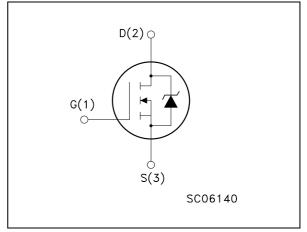


Table 1. Device summary

Order codes	Marking	Package	Packaging
STB80NF03L-04	80NF03L-04	I ² PAK	Tube

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1 Electrical ratings

Table 2.	Absolute	maximum	ratings
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Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	30	V
V _{GS}	Gate- source voltage	±20	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25°C	80	А
I _D ⁽¹⁾	Drain current (continuous) at T _C = 100°C	80	А
$I_{DM}^{(2)}$	Drain current (pulsed)	320	А
P _{TOT}	Total dissipation at $T_{C} = 25^{\circ}C$	300	W
	Derating factor	2	W/°C
dv/dt ⁽³⁾	Peak diode recovery voltage slope	2	V/ns
$E_{AS}^{(4)}$	Single pulse avalanche energy	2.3	J
T _{stg} Tj	Storage temperature Operating junction temperature	-60 to 175	°C

1. Limited by package

2. Pulse width limited by safe operating area

3. $I_{SD} \leq 80A$, di/dt $\leq 240 \text{ A/}\mu\text{s}$, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq T_{JMAX}$

4. Starting Tj = 25°C, I_D = 80 A, V_{DD} = 50 V

Table 3. Thermal data

Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case Max	0.5	°C/W
Rthj-amb	Thermal resistance junction-ambient Max	62.5	°C/W
Τ _Ι	Maximum lead temperature for soldering purpose	300	°C



2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_{D} = 250 \mu A, V_{GS} = 0$	30			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = Max rating V _{DS} = Max rating @125°C			1 10	μΑ μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	$V_{GS} = \pm 20V$			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1			V
R _{DS(on)}	Static drain-source on- resistance	$V_{GS} = 10V$, $I_D = 40A$ $V_{GS} = 4.5V$, $I_D = 40A$		0.0035 0.004	0.004 0.0055	Ω Ω

Table 4. On/off states

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	$V_{DS} = 15V_{,}I_{D} = 15A$	-	50	-	S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} = 25V, f = 1 MHz, V _{GS} = 0	-	5500 1670 290	-	pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 24V, I_D = 80A,$ $V_{GS} = 4.5V$ (see Figure 15)	-	85 23 40	110	nC nC nC

1. Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off-delay time Fall time	$V_{DD} = 15V, I_D = 40A,$ $R_G = 4.7\Omega, V_{GS} = 4.5V$ (see Figure 16)	-	30 270 110 95	-	ns ns ns ns



Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
I _{SD}	Source-drain current		-		80	А
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		320	А
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 80A, V_{GS} = 0$	-		1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} =80A, V_{DD} = 20V di/dt = 100A/µs, T_j =150°C	-	75 0.15 4		ns μC Α

 Table 7.
 Source drain diode

1. Pulse width limited by safe operating area

2. Pulse duration=300 μ s, duty cycle 1.5%



 $Z_{th} = k R_{thJ-c}$

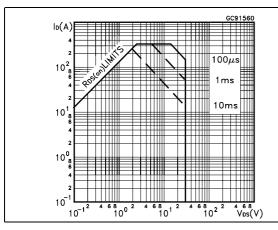
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 $\delta = t_{\rm p}/\tau$

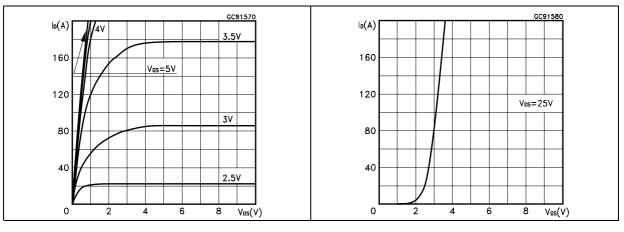
† p (s)

2.1 Electrical characteristics (curves)

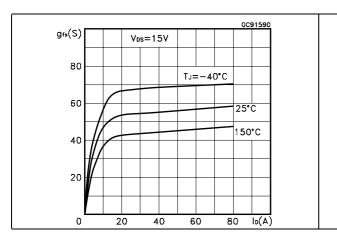
Figure 2. Safe operating area













Thermal impedance

0.02

₩0.01

10-3

10-2

Transfer characteristics

10-1

SINGLE PULSE

10-4

Figure 3.

 $\delta = 0.5$

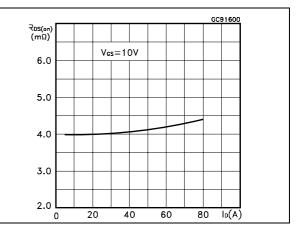
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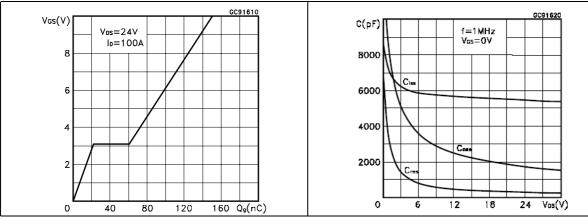
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10⁻² 10⁻⁵

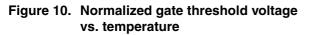
Figure 5.







Gate charge vs. gate-source voltage Figure 9. Capacitance variations Figure 8.



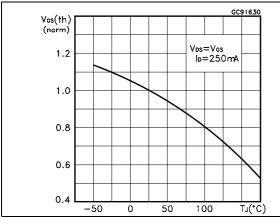


Figure 12. Source-drain diode forward characteristics

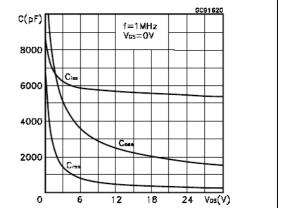
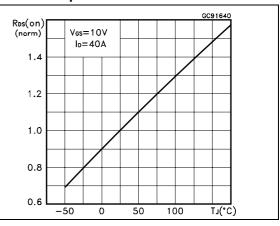
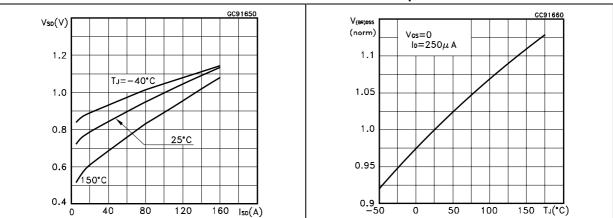


Figure 11. Normalized on-resistance vs. temperature



Normalized breakdown voltage vs Figure 13. temperature



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3 **Test circuits**

Figure 14. Switching times test circuit for resistive load

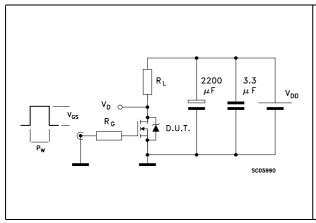
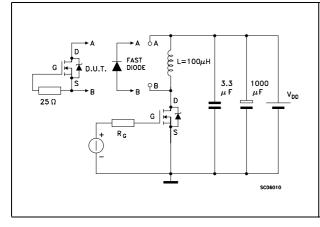
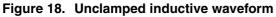


Figure 16. Test circuit for inductive load switching and diode recovery times





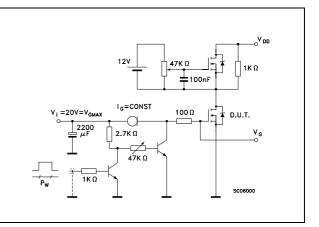
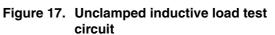


Figure 15. Gate charge test circuit



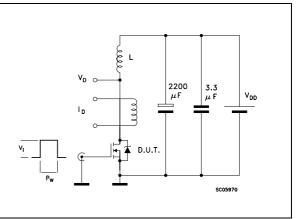
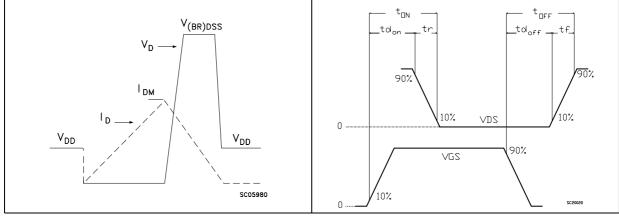


Figure 19. Switching time waveform





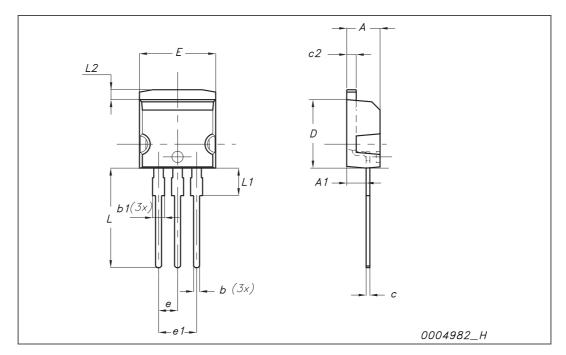
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.



I ² PAK	(TO-262)	mechanical	data
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Dim	mm			inch		
	Min	Тур	Max	Min	Тур	Max
A	4.40		4.60	0.173		0.181
A1	2.40		2.72	0.094		0.107
b	0.61		0.88	0.024		0.034
b1	1.14		1.70	0.044		0.066
С	0.49		0.70	0.019		0.027
c2	1.23		1.32	0.048		0.052
D	8.95		9.35	0.352		0.368
е	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
E	10		10.40	0.393		0.410
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L2	1.27		1.40	0.050		0.055



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5 Revision history

Table 8.Document revision history

Date	Revision	Changes
01-Oct-2009	1	Initial release



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